

SSM6N04FU

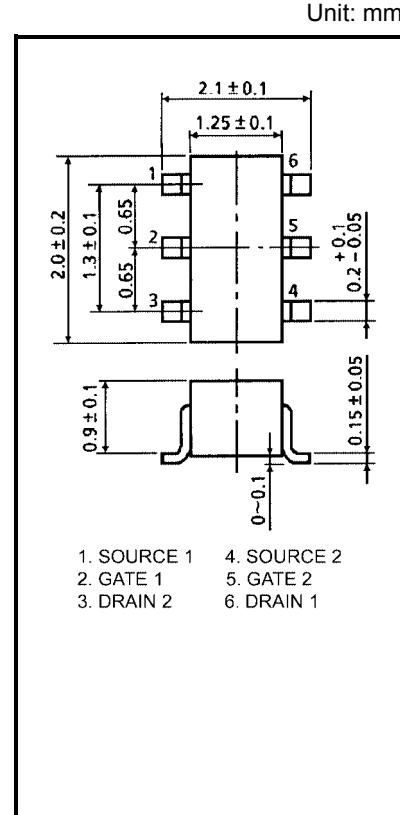
High Speed Switch Applications

- With built-in gate-source resistor: $R_{GS} = 1 \text{ M}\Omega$ (typ.)
- 2.5 V gate drive
- Low gate threshold voltage: $V_{th} = 0.7 \sim 1.3 \text{ V}$
- Small package

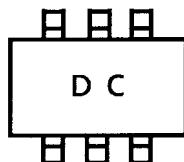
Maximum Ratings (Ta = 25°C) (Q1, Q2 common)

Characteristics	Symbol	Rating	Unit
Drain-source voltage	V_{DS}	20	V
Gate-source voltage	V_{GSS}	10	V
DC drain current	I_D	100	mA
Drain power dissipation	P_D (Note)	200	mW
Channel temperature	T_{ch}	150	°C
Storage temperature range	T_{stg}	-55~150	°C

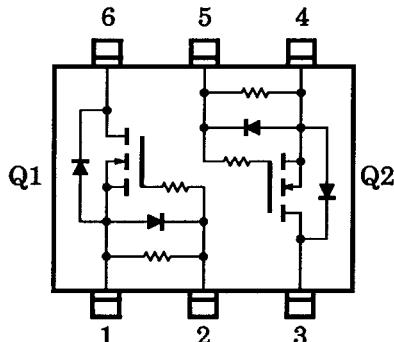
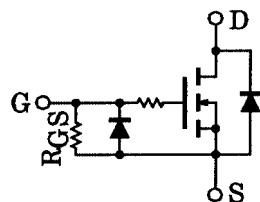
Note: Total rating



Weight: 6.8 mg (typ.)

Marking

(Q1, Q2 common)

Pin Assignment (top view)**Equivalent Circuit**

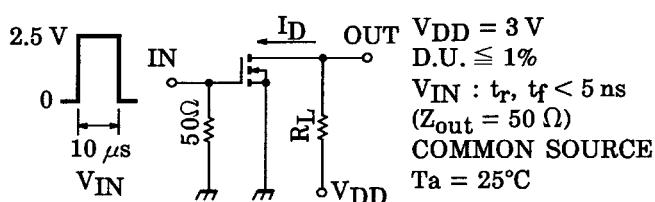
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Electrical Characteristics ($T_a = 25^\circ\text{C}$) (Q1, Q2 common)

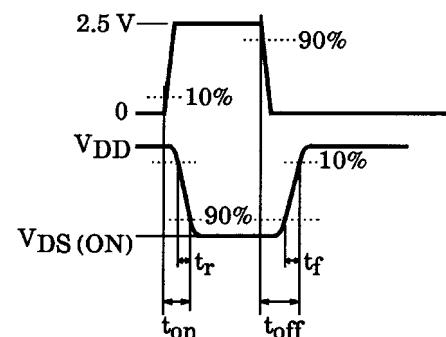
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current	I_{GSS}	$V_{GS} = 10 \text{ V}, V_{DS} = 0$	—	—	15	μA
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$I_D = 100 \mu\text{A}, V_{GS} = 0$	20	—	—	V
Drain cut-off current	I_{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0$	—	—	1	μA
Gate threshold voltage	V_{th}	$V_{DS} = 3 \text{ V}, I_D = 0.1 \text{ mA}$	0.7	—	1.3	V
Forward transfer admittance	$ Y_{fs} $	$V_{DS} = 3 \text{ V}, I_D = 10 \text{ mA}$	25	50	—	mS
Drain-source ON resistance	$R_{DS(\text{ON})}$	$I_D = 10 \text{ mA}, V_{GS} = 2.5 \text{ V}$	—	4	12	Ω
Input capacitance	C_{iss}	$V_{DS} = 3 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	—	11.0	—	pF
Reverse transfer capacitance	C_{rss}	$V_{DS} = 3 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	—	3.3	—	pF
Output capacitance	C_{oss}	$V_{DS} = 3 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	—	9.3	—	pF
Switching time	Turn-on time	t_{on}	$V_{DD} = 3 \text{ V}, I_D = 10 \text{ mA}, V_{GS} = 0\text{--}2.5 \text{ V}$	—	0.16	—
	Turn-off time	t_{off}	$V_{DD} = 3 \text{ V}, I_D = 10 \text{ mA}, V_{GS} = 0\text{--}2.5 \text{ V}$	—	0.19	—
Gate-source resistor	R_{GS}	$V_{GS} = 0\text{--}10 \text{ V}$	0.7	1.0	1.3	$\text{M}\Omega$

Switching Time Test Circuit

(a) Test circuit



(b) V_{IN}
 V_{GS}



(c) V_{OUT}
 V_{DS}

